SN74CBT3125 QUADRUPLE BUS SWITCH

SCDS021C - MAY 1995 - REVISED MARCH 1997

14 🛛 V<u>CC</u>

13 40E

12 🛛 4A

11 **1** 4B

10 30E

9 3A

8 🛛 3B

16

Vcc

15 40E

14 **1** 4A

13 4B

11 🛛 3A

10 3B

9 I NC

12 30E

D, DB, OR PW PACKAGE

(TOP VIEW)

10E

1A [2

20E 4

2A 🛛 5

2B 🛛

GND [

6

7

1B 🛛 3

- Standard '125-Type Pinout
- **5-**Ω Switch Connection Between Two Ports
- **TTL-Compatible Input and Output Levels**
- **Package Options Include Plastic** Small-Outline (D), Shrink Small-Outline (DB), Quarter-Size Small-Outline (DBQ), and Thin Shrink Small-Outline (PW) Packages

description

The SN74CBT3125 quadruple bus switch features independent line switches. Each switch is disabled when the associated output-enable (OE) input is high.

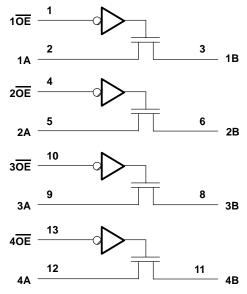
The SN74CBT3125 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE				
	INPUTS/ OUTPUTS			
UE	А, В			
L	A = B			
Н	Z			

logic diagram (positive logic)

DBQ PACKAGE (TOP VIEW) NC 1<mark>OE</mark> 2 1A [3 1B 4 2<mark>0E</mark> 5 2A 6 2B 🛛 7 GND 8

NC - No internal connection



Pin numbers shown are for the D, DB, and PW packages.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC} Input voltage range, V _I (see Note 1)		
Continuous channel current		
Input clamp current, I_{K} ($V_{I/O} < 0$)		
Package thermal impedance, θ_{JA} (see Note 2)): D package	127°C/W
	DB package	158°C/W
	DBQ package	139°C/W
	PW package	170°C/W
Storage temperature range, T _{stg}		–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51.

recommended operating conditions

		MIN	MAX	UNIT
V _{CC}	Supply voltage	4	5.5	V
VIH	High-level control input voltage	2		V
VIL	Low-level control input voltage		0.8	V
Τ _Α	Operating free-air temperature	-40	85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PA	PARAMETER TEST CONDITIONS		MIN	TYP‡	MAX	UNIT		
VIK		$V_{CC} = 4 V,$	lj = -18 mA				-1.2	V
I		V _{CC} = 5.5 V,	$V_{I} = 5.5 V \text{ or GND}$				±1	μΑ
ICC		V _{CC} = 5.5 V,	I _O = 0,	$V_I = V_{CC}$ or GND			3	μΑ
∆ICC§	Control pins	V _{CC} = 5.5 V,	One input at 3.4 V,	Other inputs at V_{CC} or GND			2.5	mA
Ci	Control pins	V _I = 3 V or 0				3		pF
C _{io(OF}	F)	$V_{O} = 3 V \text{ or } 0,$	$\overline{OE} = V_{CC}$			4		pF
		$V_{CC} = 4 V,$	V _I = 2.4 V,	lj = 15 mA		16	22	
ron¶		$V_{CC} = 4.5 V$ $V_{I} = 0$	V 0	lj = 64 mA		5	7	7 Ω
			lı = 30 mA		5	7	52	
			V _I = 2.4 V,	lı = 15 mA		10	15	

[‡] All typical values are at V_{CC} = 5 V, T_A = 25° C.

§ This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

¶ Measured by the voltage drop between the A and the B terminals at the indicated current through the switch. On-state resistance is determined by the lower voltage of the two (A or B) terminals.



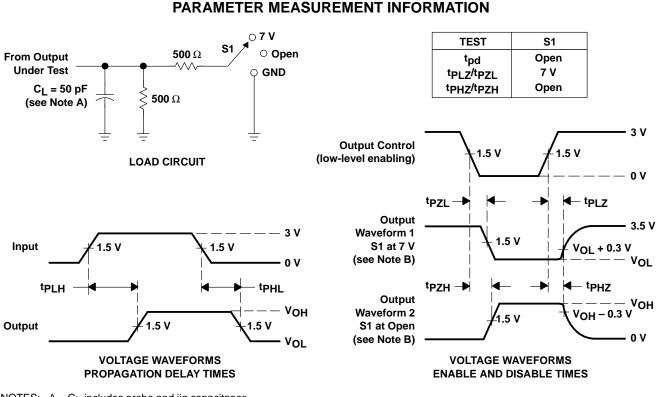
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switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

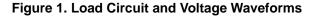
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 5 V ± 0.5 V		V _{CC} = 4 V		UNIT
		(001F01)	MIN	MAX	MIN	MAX	
t _{pd} †	A or B	B or A		0.25		0.25	ns
ten	OE	A or B	1.6	5.4		6	ns
^t dis	OE	A or B	1	4.7		5.1	ns

[†] This parameter is warranted but not production tested. The propagation delay is based on the RC time constant of the typical on-state resistance of the switch and a load capacitance of 50 pF, when driven by an ideal voltage source (zero output impedance).



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_Q = 50 Ω, t_f ≤ 2.5 ns, t_f ≤ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. tPLH and tPHL are the same as tpd.





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